

## Description

Complement to the 2N6987

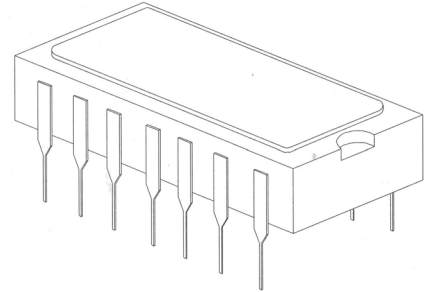
Semicoa Semiconductors offers:

- Screening and processing per MIL-PRF-19500 Appendix E
- JAN level (2N6987J)
- JANTX level (2N6987JX)
- JANTXV level (2N6987JV)
- JANS level (2N6987JS)
- QCI to the applicable level
- 100% die visual inspection per MIL-STD-750 method 2072 for JANTXV and JANS
- Radiation testing (total dose) upon request

Please contact Semicoa for special configurations  
[www.SEMICOA.com](http://www.SEMICOA.com) or (714) 979-1900

## Applications

- General purpose switching
- 4 Transistor Array
- NPN silicon transistor



## Features

- Hermetically sealed Cerdip ceramic
- Also available in chip configuration
- Chip geometry 0400
- Reference document: MIL-PRF-19500/559

## Benefits

- Qualification Levels: JAN, JANTX, JANTXV and JANS
- Radiation testing available

Absolute Maximum Ratings		$T_C = 25^\circ\text{C}$ unless otherwise specified	
Parameter	Symbol	Rating	Unit
Collector-Emitter Voltage	$V_{CEO}$	50	Volts
Collector-Base Voltage	$V_{CBO}$	75	Volts
Emitter-Base Voltage	$V_{EBO}$	6	Volts
Collector Current, Continuous	$I_C$	800	mA
Power Dissipation, $T_A = 25^\circ\text{C}$ Derate linearly above $25^\circ\text{C}$	$P_T$	2 11.43	W mW/ $^\circ\text{C}$
Operating Junction Temperature	$T_J$	-65 to +200	$^\circ\text{C}$
Storage Temperature	$T_{STG}$	-65 to +200	$^\circ\text{C}$

**ELECTRICAL CHARACTERISTICS**

characteristics specified at  $T_A = 25^\circ\text{C}$

Off Characteristics						
Parameter	Symbol	Test Conditions	Min	Typ	Max	Units
Collector-Emitter Breakdown Voltage	$V_{(BR)CEO}$	$I_C = 10 \text{ mA}$	50			Volts
Collector-Base Cutoff Current	$I_{CBO1}$	$V_{CB} = 75 \text{ Volts}$			10	$\mu\text{A}$
	$I_{CBO2}$	$V_{CB} = 60 \text{ Volts}$			10	nA
Collector-Base Cutoff Current	$I_{CBO3}$	$V_{CB} = 60 \text{ Volts}, T_A = 150^\circ\text{C}$			10	$\mu\text{A}$
Emitter-Base Cutoff Current	$I_{EBO1}$	$V_{EB} = 6 \text{ Volts}$			10	$\mu\text{A}$
	$I_{EBO2}$	$V_{EB} = 4 \text{ Volts}$			10	nA

On Characteristics			Pulse Test: Pulse Width = 300 $\mu\text{s}$ , Duty Cycle $\leq 2.0\%$			
Parameter	Symbol	Test Conditions	Min	Typ	Max	Units
DC Current Gain	$h_{FE1}$	$I_C = 0.1 \text{ mA}, V_{CE} = 10 \text{ Volts}$	50			
	$h_{FE2}$	$I_C = 1.0 \text{ mA}, V_{CE} = 10 \text{ Volts}$	75		325	
	$h_{FE3}$	$I_C = 10 \text{ mA}, V_{CE} = 10 \text{ Volts}$	100			
	$h_{FE4}$	$I_C = 150 \text{ mA}, V_{CE} = 10 \text{ Volts}$	100		300	
	$h_{FE5}$	$I_C = 500 \text{ mA}, V_{CE} = 10 \text{ Volts}$	30			
	$h_{FE6}$	$I_C = 10 \text{ mA}, V_{CE} = 10 \text{ Volts}$ $T_A = -55^\circ\text{C}$	35			
Base-Emitter Saturation Voltage	$V_{BEsat1}$	$I_C = 150 \text{ mA}, I_B = 15 \text{ mA}$	0.6		1.2	Volts
	$V_{BEsat2}$	$I_C = 500 \text{ mA}, I_B = 50 \text{ mA}$			2.0	
Collector-Emitter Saturation Voltage	$V_{CEsat1}$	$I_C = 150 \text{ mA}, I_B = 15 \text{ mA}$			0.3	Volts
	$V_{CEsat2}$	$I_C = 500 \text{ mA}, I_B = 50 \text{ mA}$			1.0	

Dynamic Characteristics						
Parameter	Symbol	Test Conditions	Min	Typ	Max	Units
Magnitude – Common Emitter, Short Circuit Forward Current Transfer Ratio	$ h_{FE} $	$V_{CE} = 20 \text{ Volts}, I_C = 20 \text{ mA}, f = 100 \text{ MHz}$	2.5		10	
Small Signal Short Circuit Forward Current Transfer Ratio	$h_{FE}$	$V_{CE} = 10 \text{ Volts}, I_C = 1 \text{ mA}, f = 1 \text{ kHz}$	50			
Open Circuit Output Capacitance	$C_{OBO}$	$V_{CB} = 10 \text{ Volts}, I_E = 0 \text{ mA}, 100 \text{ kHz} < f < 1 \text{ MHz}$			8	pF
Open Circuit Input Capacitance	$C_{IBO}$	$V_{EB} = 2 \text{ Volts}, I_C = 0 \text{ mA}, 100 \text{ kHz} < f < 1 \text{ MHz}$			25	pF
Transistor to Transistor Resistance	$ R_{T-T} $	$ V_{T-T}  = 500 \text{ Volts}$	$10^{10}$			$\Omega$

Switching Characteristics						
Parameter	Symbol	Test Conditions	Min	Typ	Max	Units
Saturated Turn-On Time	$t_{ON}$				35	ns
Saturated Turn-Off Time	$t_{OFF}$				300	ns